

# AONS66614

60V N-Channel AlphaSGT™

# **General Description**

- Trench Power AlphaSGT<sup>™</sup> technology
- Low R<sub>DS(ON)</sub>
- Logic Level Driving
- Excellent Q<sub>G</sub> x R<sub>DS(ON)</sub> Product (FOM)
- RoHS and Halogen-Free Compliant

# **Applications**

• High Frequency Switching and Synchronous Rectification

## **Product Summary**

 $\begin{array}{lll} V_{DS} & 60V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 85A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 2.9 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 4.1 m\Omega \end{array}$ 

100% UIS Tested 100% Rg Tested



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Orderable Part Number	Package Type	Form	Minimum Order Quantity		
AONS66614	DFN 5x6	Tape & Reel	3000		
Absolute Maximum Ratings, T. –25°C unless otherwise noted					

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage Gate-Source Voltage		V <sub>DS</sub>	60	V	
		$V_{GS}$	±20	V	
Continuous Drain	T <sub>C</sub> =25°C		85		
Current <sup>G</sup>	T <sub>C</sub> =100°C	I <sub>D</sub>	77	A	
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	245		
Continuous Drain Current	T <sub>A</sub> =25°C		34.5	А	
	T <sub>A</sub> =70°C	IDSM	27.5	<b>7</b>	
Avalanche Current <sup>(</sup>		I <sub>AS</sub>	32	A	
Avalanche energy	L=0.3mH <sup>C</sup>	E <sub>AS</sub>	154	mJ	
Power Dissipation <sup>B</sup>	T <sub>C</sub> =25°C	P <sub>D</sub>	78	W	
	T <sub>C</sub> =100°C	' D	31	VV	
Power Dissipation <sup>A</sup>	T <sub>A</sub> =25°C	P <sub>DSM</sub>	6.2	W	
	T <sub>A</sub> =70°C	DSM	4.0	VV	
Junction and Storag	e Temperature Range	$T_J$ , $T_{STG}$	-55 to 150	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Units		
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta,JA}$	15	20	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	Т⊕ЈА	40	50	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.3	1.6	°C/W	



#### Electrical Characteristics (T<sub>.</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		60			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ =60V, $V_{GS}$ =0V	$V_{DS}$ =60V, $V_{GS}$ =0V			1	μA
DSS	Zero Gate Voltage Drain Gurrent		T <sub>J</sub> =55°C			5	μΑ
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS,}I_{D}=250\mu A$		1.2	1.8	2.4	V
	Static Drain-Source On-Resistance	$V_{GS}$ =10V, $I_D$ =20A			2.4	2.9	mΩ
$R_{DS(ON)}$			T <sub>J</sub> =125°C		3.85	4.7	11152
		$V_{GS}$ =4.5V, $I_D$ =20A			3.1	4.1	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =20A			100		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			0.69	1	V
Is	Maximum Body-Diode Continuous Curr	ent <sup>G</sup>				85	Α
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =30V, f=1MHz			3310		pF
Coss	Output Capacitance				745		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				30		pF
$R_g$	Gate resistance	f=1MHz		0.5	1.1	1.7	Ω
SWITCHI	NG PARAMETERS						
<b>Q</b> <sub>g</sub> (10V)	Total Gate Charge	-V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =20A			51	75	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge				25	38	nC
$Q_{gs}$	Gate Source Charge				10		nC
$Q_{gd}$	Gate Drain Charge				8.5		nC
$Q_{oss}$	Output Charge	$V_{GS}=0V$ , $V_{DS}=30V$			46		nC
t <sub>D(on)</sub>	Turn-On DelayTime				11		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =30V, $R_L$ =1.5 $\Omega$ , $R_{GEN}$ =3 $\Omega$			6		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				43		ns
t <sub>f</sub>	Turn-Off Fall Time				12		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, di/dt=500A/μs			22		ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, di/dt=500A/μs			73		nC

A. The value of  $R_{0JA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The Power dissipation P<sub>DSM</sub> is based on R  $_{0.JA}$  t≤ 10s and the maximum allowed junction temperature of 150 $^{\circ}$  C. The value in any given application depends on the user's specific board design.

- C. Single pulse width limited by junction temperature  $T_{J(MAX)}\!\!=\!\!150^\circ\,$  C.
- D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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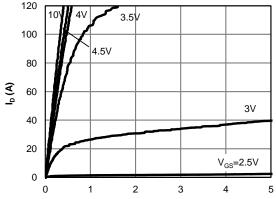
B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

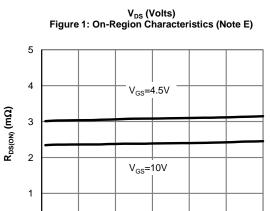
E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.



## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





0

0

5

10

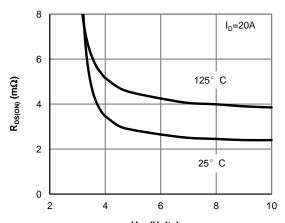
 $I_{\rm D}$  (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

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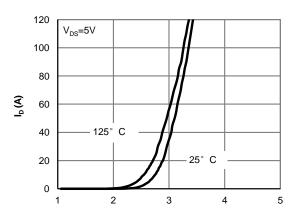
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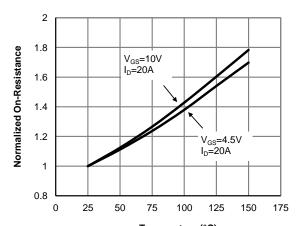
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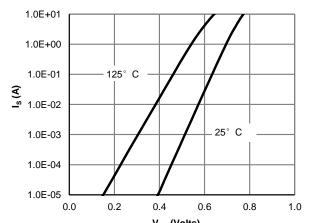
V<sub>GS</sub> (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V<sub>GS</sub> (Volts) Figure 2: Transfer Characteristics (Note E)



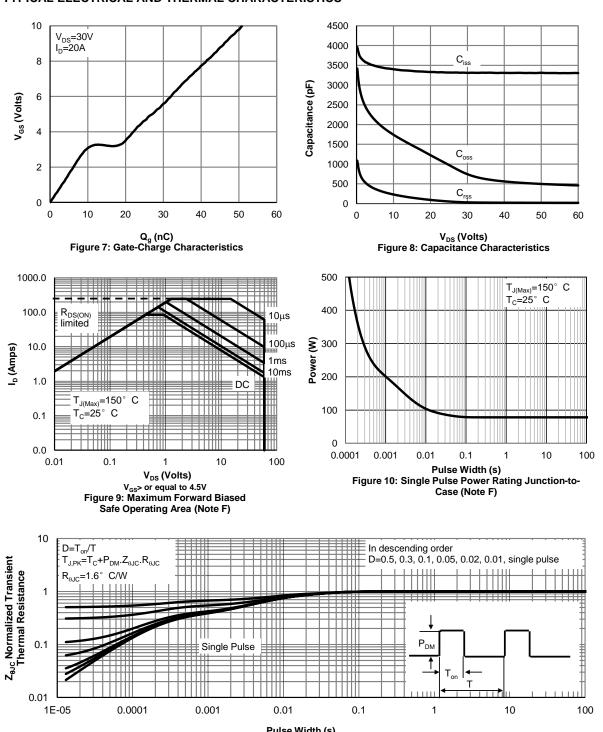
Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)



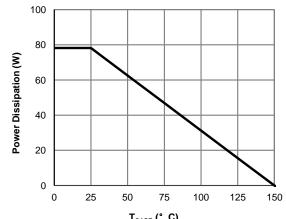
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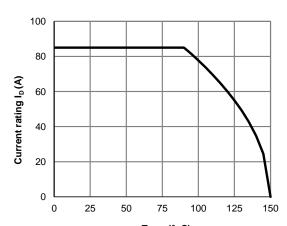
Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



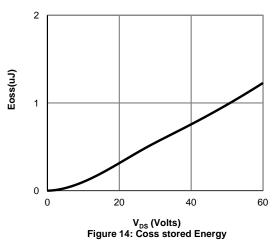
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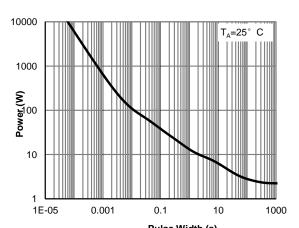


T<sub>CASE</sub> (° C)
Figure 12: Power De-rating (Note F)

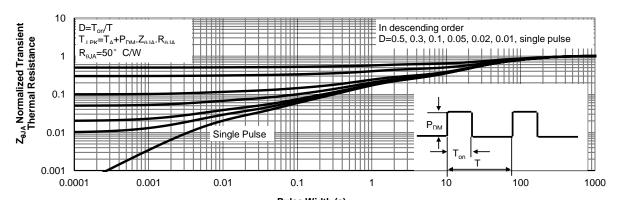


T<sub>CASE</sub> (° C)
Figure 13: Current De-rating (Note F)





Pulse Width (s)
Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)



Figure A: Gate Charge Test Circuit & Waveforms

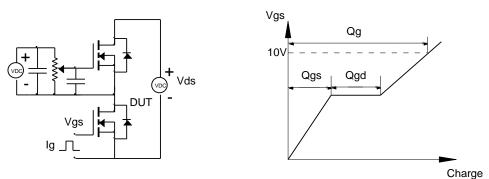


Figure B: Resistive Switching Test Circuit & Waveforms

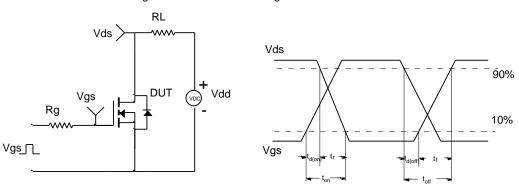


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

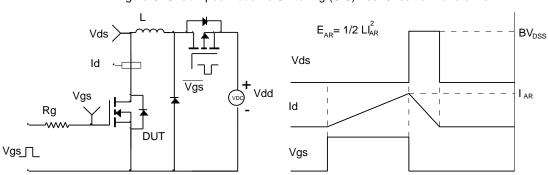


Figure D: Diode Recovery Test Circuit & Waveforms

